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Table of Contents-

1.	GENE	RAL DESCRIPTION					
2.	FEAT	URES					
3.	ORDI	R INFORMATION					
4.	KEY	Y PARAMETERS					
5.	PIN C	ONFIGUR	ATION	6			
6.	PIN D	ESCRIPTI	ON	7			
7.	BLOC	K DIAGRA	CDIAGRAM				
8.	FUNC	TIONAL D	ESCRIPTION	9			
	8.1	Power Up Sequence					
	8.2	Commar	nd Function	10			
		8.2.1	Bank Activate Command	10			
		8.2.2	Bank Precharge Command	10			
		8.2.3	Precharge All Command	10			
		8.2.4	Write Command	10			
		8.2.5	Write with Auto-precharge Command	10			
		8.2.6	Read Command	10			
		8.2.7	Read with Auto-precharge Command	10			
		8.2.8	Mode Register Set Command	11			
		8.2.9	Extended Mode Register Set Command	11			
		8.2.10	No-Operation Command	11			
		8.2.11	Burst Read Stop Command	11			
		8.2.12	Device Deselect Command	11			
		8.2.13	Auto Refresh Command	11			
		8.2.14	Self Refresh Entry Command	12			
		8.2.15	Self Refresh Exit Command	12			
		8.2.16	Data Write Enable /Disable Command	12			
	8.3	Read Op	peration	12			
	8.4	Write Op	eration	13			
	8.5	Precharg	je	13			
	8.6	Burst Te	rmination	13			
	8.7	Refresh Operation		13			
	8.8	Power Down Mode					
	8.9	Input Clo	ck Frequency Change during Precharge Power Down Mode	14			
	8.10	Mode Re	egister Operation	14			
		8.10.1	Burst Length field (A2 to A0)	14			
		8.10.2	Addressing Mode Select (A3)	. 15			
		8.10.3	CAS Latency field (A6 to A4)	16			
		8.10.4	DLL Reset bit (A8)	16			
		8.10.5	Mode Register / Extended Mode register change bits (BA0, BA1)	16			

		8.10.6 Extended Mode Register field	16
		8.10.7 Reserved field	16
9.	OPER	ATION MODE	17
	9.1	Simplified Truth Table	17
	9.2	Function Truth Table	18
	9.3	Function Truth Table for CKE	21
	9.4	Simplified Stated Diagram	22
10.	ELEC	TRICAL CHARACTERISTICS	23
	10.1	Absolute Maximum Ratings	23
	10.2	Recommended DC Operating Conditions	23
	10.3	Capacitance	24
	10.4	Leakage and Output Buffer Characteristics	24
	10.5	DC Characteristics	25
	10.6	AC Characteristics and Operating Condition	26
	10.7	AC Test Conditions	27
11.	SYSTI	EM CHARACTERISTICS FOR DDR SDRAM	29
	11.1	Table 1: Input Slew Rate for DQ, DQS, and DM	29
	11.2	Table 2: Input Setup & Hold Time Derating for Slew Rate	29
	11.3	Table 3: Input/Output Setup & Hold Time Derating for Slew Rate	29
	11.4	Table 4: Input/Output Setup & Hold Derating for Rise/Fall Delta Slew Rate	29
	11.5	Table 5: Output Slew Rate Characteristics (x16 Devices only)	29
	11.6	Table 6: Output Slew Rate Matching Ratio Characteristics	30
	11.7	Table 7: AC Overshoot/Undershoot Specification for Address and Control Pins	30
	11.8	Table 8: Overshoot/Undershoot Specification for Data, Strobe, and Mask Pins	31
	11.9	System Notes:	32
12.	TIMIN	G WAVEFORMS	34
	12.1	Command Input Timing	34
	12.2	Timing of the CLK Signals	34
	12.3	Read Timing (Burst Length = 4)	35
	12.4	Write Timing (Burst Length = 4)	36
	12.5	DM, DATA MASK (W9412G6KH)	37
	12.6	Mode Register Set (MRS) Timing	38
	12.7	Extend Mode Register Set (EMRS) Timing	39
	12.8	Auto-precharge Timing (Read Cycle, CL = 2)	40
	12.9	Auto-precharge Timing (Read cycle, CL = 2), continued	41
	12.10	Auto-precharge Timing (Write Cycle)	42
	12.11	Read Interrupted by Read (CL = 2, BL = 2, 4, 8)	43
	12.12	Burst Read Stop (BL = 8)	43
	12.13	Read Interrupted by Write & BST (BL = 8)	44
	12.14	Read Interrupted by Precharge (BL = 8)	44
	12.15	Write Interrupted by Write (BL = 2, 4, 8)	45
	12.16	Write Interrupted by Read (CL = 2, BL = 8)	45
	12.17	Write Interrupted by Read (CL = 3, BL = 4)	46
	12.18	Write Interrupted by Precharge (BL = 8)	46
	12.19	2 Bank Interleave Read Operation (CL = 2, BL = 2)	47

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	12.20	2 Bank Interleave Read Operation (CL = 2, BL = 4)	47
	12.21	4 Bank Interleave Read Operation (CL = 2, BL = 2)	48
	12.22	4 Bank Interleave Read Operation (CL = 2, BL = 4)	48
	12.23	Auto Refresh Cycle	49
	12.24	Precharge/Activate Power Down Mode Entry and Exit Timing	49
	12.25	Input Clock Frequency Change during Precharge Power Down Mode Timing	49
	12.26	Self Refresh Entry and Exit Timing	50
13.	PACKA	GE SPECIFICATION	51
14.	REVISI	ON HISTORY	52

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1. GENERAL DESCRIPTION

W9412G6KH is a CMOS Double Data Rate synchronous dynamic random access memory (DDR SDRAM); organized as 2M words \times 4 banks \times 16 bits. W9412G6KH delivers a data bandwidth of up to 400M words per second. To fully comply with the personal computer industrial standard, W9412G6KH is sorted into the following speed grades: -5, -51 and -61.

The -5/-5I grades are compliant to the DDR400/CL3 specification (the -5I industrial grade which is guaranteed to support -40°C \leq TA \leq 85°C).

The -6I industrial grade is compliant to the DDR333/CL3 specification which is guaranteed to support -40°C \leq TA \leq 85°C.

All Inputs reference to the positive edge of CLK (except for DQ, DM and CKE). The timing reference point for the differential clock is when the CLK and \overline{CLK} signals cross during a transition. Write and Read data are synchronized with the both edges of DQS (Data Strobe).

By having a programmable Mode Register, the system can change burst length, latency cycle, interleave or sequential burst to maximize its performance. W9412G6KH is ideal for any high performance applications.

2. FEATURES

- $2.5V \pm 0.2V$ Power Supply for DDR400/333
- Up to 200 MHz Clock Frequency
- Double Data Rate architecture; two data transfers per clock cycle
- Differential clock inputs (CLK and \overline{CLK})
- DQS is edge-aligned with data for Read; center-aligned with data for Write
- CAS Latency: 2, 2.5 and 3
- Burst Length: 2, 4 and 8
- Auto Refresh and Self Refresh
- Precharged Power Down and Active Power Down
- Write Data Mask
- Write Latency = 1
- 15.6µS Refresh interval (4K/64 mS Refresh)
- Maximum burst refresh cycle: 8
- Interface: SSTL_2
- Packaged in TSOP II 66-pin, using Lead free materials with RoHS compliant

3. ORDER INFORMATION

PART NUMBER	SPEED	SELF REFRESH CURRENT (MAX.)	OPERATING TEMPERATURE
W9412G6KH-5	DDR400/CL3	2 mA	0°C ~ 70°C
W9412G6KH-5I	DDR400/CL3	2 mA	-40°C ~ 85°C
W9412G6KH-6I	DDR333/CL3	2 mA	-40°C ~ 85°C



4. KEY PARAMETERS

SYMBOL	DESCRIPTION		MIN/MAX.	-5/-5I	-61
			Min.	7.5 nS	7.5 nS
		UL = 2	Max.	12 nS	12 nS
tor	Clock Cycle Time	$C_{1} = 2.5$	Min.	6 nS	6 nS
ICK		OL = 2.5	Max.	12 nS	12 nS
			Min.	5 nS	6 nS
		CL = 3	Max.	12 nS	12 nS
tRAS	Active to Precharge Command Period		Min.	40 nS	42 nS
tRC	Active to Ref/Active Command Period		Min.	50 nS	54 nS
IDD0	Operating Current: One Bank Active-Precharge		Max.	55 mA	50 mA
IDD1	Operating Current: One Bank Active-Re	ad-Precharge	Max.	65 mA	55 mA
IDD4R	Burst Operation Current		Max.	120 mA	110 mA
IDD4W	Burst Operation Current		Max.	115 mA	100 mA
IDD5	Auto Refresh Burst current		Max.	70 mA	65 mA
IDD6	Self-Refresh Current		Max.	2 mA	2 mA



5. PIN CONFIGURATION

Van [Vec
		V35
	3 64	
	5 62	
VssQ	6 61	
DO3	7 60	DQ12
DQ4	8 59	 DQ11
VDDQ	9 58	Vssq
DQ5	10 57	 DQ10
DQ6	11 56	 DQ9
Vssa	12 55	VDDQ
 DQ7	13 54	DQ8
NC	14 53	NC
VDDQ	15 52	Vssa
LDQS	16 51	UDQS
NC	17 50	NC
VDD	18 49	VREF
NC	19 48	Vss
LDM	20 47	UDM
WE	21 46	CLK
CAS	22 45	CLK
RAS	23 44	СКЕ
	24 43	
	25 42	
BA0	26 41	A11
BA1	27 40	A9
A10/AP	28 39	
	29 38	
VDD		vəs



PIN NUMBER	PIN NAME	FUNCTION	DESCRIPTION
28 - 32, 35 - 41	A0 – A11	Address	Multiplexed pins for row and column address. Row address: A0 – A11.Column address: A0 – A8. Provide the row address for Bank Activate commands, and the column address and Auto-precharge bit (A10) for Read/Write commands, to select one location out of the memory array in the respective bank. A10 is sampled during a precharge command to determine whether the precharge applies to one bank (A10 Low) or all banks (A10 High). If only one bank is to be precharged, the bank is selected by BA0, BA1. The address inputs also provide the op-code during a Mode Register Set command. BA0 and BA1 define which mode register is loaded during the Mode Register Set command (MRS or EMRS).
26, 27	BA0, BA1	Bank Select	Select bank to activate during row address latch time, or bank to read/write during column address latch time.
2, 4, 5, 7, 8, 10, 11, 13, 54, 56, 57, 59, 60, 62, 63, 65	DQ0 – DQ15	Data Input/ Output	The DQ0 – DQ15 input and output data are synchronized with both edges of DQS.
16,51	LDQS, UDQS	Data Strobe	DQS is Bi-directional signal. DQS is input signal during write operation and output signal during read operation. It is Edge- aligned with read data, Center-aligned with write data.
24	CS	Chip Select	Disable or enable the command decoder. When command decoder is disabled, new command is ignored and previous operation continues.
23, 22, 21	$\overline{RAS}, \\ \overline{CAS}, \ \overline{WE}$	Command Inputs	Command inputs (along with $\overline{\text{CS}}$) define the command being entered.
20, 47	LDM, UDM	Write Mask	When DM is asserted "high" in burst write, the input data is masked. DM is synchronized with both edges of DQS.
45, 46	CLK, CLK	Differential Clock Inputs	All address and control input signals are sampled on the crossing of the positive edge of CLK and negative edge of $\overrightarrow{\text{CLK}}$.
44	CKE	Clock Enable	CKE controls the clock activation and deactivation. When CKE is low, Power Down mode, Suspend mode, or Self Refresh mode is entered.
49	VREF	Reference Voltage	VREF is reference voltage for inputs.
1, 18, 33	Vdd	Power	Power for logic circuit inside DDR SDRAM.
34, 48, 66	Vss	Ground	Ground for logic circuit inside DDR SDRAM.
3, 9, 15, 55, 61	Vddq	Power for I/O Buffer	Separated power from V_{DD} , used for output buffer, to improve noise.
6, 12, 52, 58, 64	Vssq	Ground for I/O Buffer	Separated ground from Vss, used for output buffer, to improve noise.
14, 17, 19, 25, 42, 43, 50, 53	NC	No Connection	No connection

7. BLOCK DIAGRAM



8. FUNCTIONAL DESCRIPTION

8.1 Power Up Sequence

(1) Apply power and attempt to CKE at a low state ($\leq 0.2V$), all other inputs may be undefined

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- 1) Apply VDD before or at the same time as VDDQ.
- 2) Apply VDDQ before or at the same time as VTT and VREF.
- (2) Start Clock and maintain stable condition for 200 μ S (min.).
- (3) After stable power and clock, apply NOP and take CKE high.
- (4) Issue precharge command for all banks of the device.
- (5) Issue EMRS (Extended Mode Register Set) to enable DLL and establish Output Driver Type.
- (6) Issue MRS (Mode Register Set) to reset DLL and set device to idle with bit A8.

(An additional 200 cycles(min) of clock are required for DLL Lock before any executable command applied.)

- (7) Issue precharge command for all banks of the device.
- (8) Issue two or more Auto Refresh commands.
- (9) Issue MRS-Initialize device operation with the reset DLL bit deactivated A8 to low.



Initialization sequence after power-up

8.2 Command Function

8.2.1 Bank Activate Command

 $(\overline{RAS} = "L", \overline{CAS} = "H", \overline{WE} = "H", BA0, BA1 = Bank, A0 to A11 = Row Address)$

The Bank Activate command activates the bank designated by the BA (Bank address) signal. Row addresses are latched on A0 to A11 when this command is issued and the cell data is read out of the sense amplifiers. The maximum time that each bank can be held in the active state is specified as tRAS (max). After this command is issued, Read or Write operation can be executed.

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8.2.2 Bank Precharge Command

 $(\overline{RAS} = "L", \overline{CAS} = "H", \overline{WE} = "L", BA0, BA1 = Bank, A10 = "L", A0 to A9, A11 = Don't Care)$

The Bank Precharge command percharges the bank designated by BA. The precharged bank is switched from the active state to the idle state.

8.2.3 Precharge All Command

 $(\overline{RAS} = "L", \overline{CAS} = "H", \overline{WE} = "L", BA0, BA1 = Don't Care, A10 = "H", A0 to A9, A11 = Don't Care)$

The Precharge All command precharges all banks simultaneously. Then all banks are switched to the idle state.

8.2.4 Write Command

(RAS = "H", CAS = "L", WE = "L", BA0, BA1 = Bank, A10 = "L", A0 to A8 = Column Address)

The write command performs a Write operation to the bank designated by BA. The write data are latched at both edges of DQS. The length of the write data (Burst Length) and column access sequence (Addressing Mode) must be in the Mode Register at power-up prior to the Write operation.

8.2.5 Write with Auto-precharge Command

 $(\overline{RAS} = "H", \overline{CAS} = "L", \overline{WE} = "L", BA0, BA1 = Bank, A10 = "H", A0 to A8 = Column Address)$

The Write with Auto-precharge command performs the Precharge operation automatically after the Write operation. This command must not be interrupted by any other commands.

8.2.6 Read Command

 $(\overline{RAS} = "H", \overline{CAS} = "L", \overline{WE} = "H", BA0, BA1 = Bank, A10 = "L", A0 to A8 = Column Address)$

The Read command performs a Read operation to the bank designated by BA. The read data are synchronized with both edges of DQS. The length of read data (Burst Length), Addressing Mode and CAS Latency (access time from \overrightarrow{CAS} command in a clock cycle) must be programmed in the Mode Register at power-up prior to the Read operation.

8.2.7 Read with Auto-precharge Command

 $(\overline{RAS} = "H", \overline{CAS} = "L", \overline{WE} = "H", BA0, BA1 = Bank, A10 = "H", A0 to A8 = Column Address)$

The Read with Auto-precharge command automatically performs the Precharge operation after the Read operation.



1) READA \geq tRAS (min) - (BL/2) x tCK

Internal precharge operation begins after BL/2 cycle from Read with Auto-precharge command.

2) $tRCD(min) \le READA < tRAS(min) - (BL/2) x tCK$

Data can be read with shortest latency, but the internal Precharge operation does not begin until after tRAS (min) has completed.

This command must not be interrupted by any other command.

8.2.8 Mode Register Set Command

 $(\overline{RAS} = "L", \overline{CAS} = "L", \overline{WE} = "L", BA0 = "L", BA1 = "L", A0 to A11 = Register Data)$

The Mode Register Set command programs the values of CAS Latency, Addressing Mode, Burst Length and DLL reset in the Mode Register. The default values in the Mode Register after power-up are undefined, therefore this command must be issued during the power-up sequence. Also, this command can be issued while all banks are in the idle state. Refer to the table for specific codes.

8.2.9 Extended Mode Register Set Command

$$(\overline{RAS} = "L", \overline{CAS} = "L", \overline{WE} = "L", BA0 = "H", BA1 = "L", A0 to A11 = Register data)$$

The Extended Mode Register Set command can be implemented as needed for function extensions to the standard (SDR-SDRAM). Currently the only available mode in EMRS is DLL enable/disable, decoded by A0. The default value of the extended mode register is not defined; therefore this command must be issued during the power-up sequence for enabling DLL. Refer to the table for specific codes.

8.2.10 No-Operation Command

 $(\overline{RAS} = "H", \overline{CAS} = "H", \overline{WE} = "H")$

The No-Operation command simply performs no operation (same command as Device Deselect).

8.2.11 Burst Read Stop Command

 $(\overline{RAS} = "H", \overline{CAS} = "H", \overline{WE} = "L")$

The Burst stop command is used to stop the burst operation. This command is only valid during a Burst Read operation.

8.2.12 Device Deselect Command

 $(\overline{\text{CS}} = \text{``H''})$

The Device Deselect command disables the command decoder so that the \overline{RAS} , \overline{CAS} , \overline{WE} and Address inputs are ignored. This command is similar to the No-Operation command.

8.2.13 Auto Refresh Command

 $(\overline{RAS} = "L", \overline{CAS} = "L", \overline{WE} = "H", CKE = "H", BA0, BA1, A0 to A11 = Don't Care)$

AUTO REFRESH is used during normal operation of the DDR SDRAM and is analogous to CAS– BEFORE–RAS (CBR) refresh in previous DRAM types. This command is non persistent, so it must be issued each time a refresh is required.

The refresh addressing is generated by the internal refresh controller. This makes the address bits "Don't Care" during an AUTO REFRESH command. The DDR SDRAM requires AUTO REFRESH cycles at an average periodic interval of tREFI (maximum).

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To allow for improved efficiency in scheduling and switching between tasks, some flexibility in the absolute refresh interval is provided. A maximum of eight AUTO REFRESH commands can be posted to any given DDR SDRAM, and the maximum absolute interval between any AUTO REFRESH command and the next AUTO REFRESH command is 8 * tREFI.

8.2.14 Self Refresh Entry Command

 $(\overline{RAS} = "L", \overline{CAS} = "L", \overline{WE} = "H", CKE = "L", BA0, BA1, A0 to A11 = Don't Care)$

The SELF REFRESH command can be used to retain data in the DDR SDRAM, even if the rest of the system is powered down. When in the self refresh mode, the DDR SDRAM retains data without external clocking. The SELF REFRESH command is initiated like an AUTO REFRESH command except CKE is disabled (LOW). The DLL is automatically disabled upon entering SELF REFRESH, and is automatically enabled upon exiting SELF REFRESH. Any time the DLL is enabled a DLL Reset must follow and 200 clock cycles should occur before a READ command can be issued. Input signals except CKE are "Don't Care" during SELF REFRESH. Since CKE is an SSTL 2 input, VREF must be maintained during SELF REFRESH.

8.2.15 Self Refresh Exit Command

 $(CKE = "H", \overline{CS} = "H" \text{ or } CKE = "H", \overline{RAS} = "H", \overline{CAS} = "H")$

The procedure for exiting self refresh requires a sequence of commands. First, CLK must be stable prior to CKE going back HIGH. Once CKE is HIGH, the DDR SDRAM must have NOP commands issued for tXSNR because time is required for the completion of any internal refresh in progress. A simple algorithm for meeting both refresh and DLL requirements is to apply NOPs for 200 clock cycles before applying any other command.

The use of SELF REFREH mode introduces the possibility that an internally timed event can be missed when CKE is raised for exit from self refresh mode. Upon exit from SELF REFRESH an extra auto refresh command is recommended.

8.2.16 Data Write Enable /Disable Command

(DM = "L/H" or LDM, UDM = "L/H")

During a Write cycle, the DM or LDM, UDM signal functions as Data Mask and can control every word of the input data. The LDM signal controls DQ0 to DQ7 and UDM signal controls DQ8 to DQ15.

8.3 Read Operation

Issuing the Bank Activate command to the idle bank puts it into the active state. When the Read command is issued after tRCD from the Bank Activate command, the data is read out sequentially, synchronized with both edges of DQS (Burst Read operation). The initial read data becomes available after CAS Latency from the issuing of the Read command. The CAS Latency must be set in the Mode Register at power-up.

When the Precharge Operation is performed on a bank during a Burst Read and operation, the Burst operation is terminated.

When the Read with Auto-precharge command is issued, the Precharge operation is performed automatically after the Read cycle then the bank is switched to the idle state. This command cannot be interrupted by any other commands. Refer to the diagrams for Read operation.

8.4 Write Operation

Issuing the Write command after tRCD from the bank activate command. The input data is latched sequentially, synchronizing with both edges(rising & falling) of DQS after the Write command (Burst write operation). The burst length of the Write data (Burst Length) and Addressing Mode must be set in the Mode Register at power-up.

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When the Precharge operation is performed in a bank during a Burst Write operation, the Burst operation is terminated.

When the Write with Auto-precharge command is issued, the Precharge operation is performed automatically after the Write cycle, then the bank is switched to the idle state, The Write with Auto-precharge command cannot be interrupted by any other command for the entire burst data duration.

Refer to the diagrams for Write operation.

8.5 Precharge

There are two Commands, which perform the precharge operation (Bank Precharge and Precharge All). When the Bank Precharge command is issued to the active bank, the bank is precharged and then switched to the idle state. The Bank Precharge command can precharge one bank independently of the other bank and hold the unprecharged bank in the active state. The maximum time each bank can be held in the active state is specified as tRAS (max). Therefore, each bank must be precharged within tRAS(max) from the bank activate command.

The Precharge All command can be used to precharge all banks simultaneously. Even if banks are not in the active state, the Precharge All command can still be issued. In this case, the Precharge operation is performed only for the active bank and the precharge bank is then switched to the idle state.

8.6 Burst Termination

When the Precharge command is used for a bank in a Burst cycle, the Burst operation is terminated. When Burst Read cycle is interrupted by the Precharge command, read operation is disabled after clock cycle of (CAS Latency) from the Precharge command. When the Burst Write cycle is interrupted by the Precharge command, the input circuit is reset at the same clock cycle at which the precharge command is issued. In this case, the DM signal must be asserted "high" during twR to prevent writing the invalided data to the cell array.

When the Burst Read Stop command is issued for the bank in a Burst Read cycle, the Burst Read operation is terminated. The Burst read Stop command is not supported during a write burst operation. Refer to the diagrams for Burst termination.

8.7 Refresh Operation

Two types of Refresh operation can be performed on the device: Auto Refresh and Self Refresh. By repeating the Auto Refresh cycle, each bank in turn refreshed automatically. The Refresh operation must be performed 4096 times (rows) within 64mS. The period between the Auto Refresh command and the next command is specified by tRFC.

Self Refresh mode enters issuing the Self Refresh command (CKE asserted "low") while all banks are in the idle state. The device is in Self Refresh mode for as long as CKE held "low". In the case of distributed Auto Refresh commands, distributed auto refresh commands must be issued every 15.6 μ S and the last distributed Auto Refresh commands must be performed within 15.6 μ S before entering the self refresh mode. After exiting from the Self Refresh mode, the refresh operation must be performed within 15.6 μ S. In Self Refresh mode, all input/output buffers are disabled, resulting in lower power dissipation (except CKE buffer). Refer to the diagrams for Refresh operation.

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8.8 Power Down Mode

Two types of Power Down Mode can be performed on the device: Active Standby Power Down Mode and Precharge Standby Power Down Mode.

When the device enters the Power Down Mode, all input/output buffers are disabled resulting in low power dissipation (except CKE buffer).

Power Down Mode enter asserting CKE "low" while the device is not running a burst cycle. Taking CKE "high" can exit this mode. When CKE goes high, a No operation command must be input at next CLK rising edge. Refer to the diagrams for Power Down Mode.

8.9 Input Clock Frequency Change during Precharge Power Down Mode

DDR SDRAM input clock frequency can be changed under following condition:

DDR SDRAM must be in precharged power down mode with CKE at logic LOW level. After a minimum of 2 clocks after CKE goes LOW, the clock frequency may change to any frequency between minimum and maximum operating frequency specified for the particular speed grade. During an input clock frequency change, CKE must be held LOW. Once the input clock frequency is changed, a stable clock must be provided to DRAM before precharge power down mode may be exited. The DLL must be RESET via EMRS after precharge power down exit. An additional MRS command may need to be issued to appropriately set CL etc. After the DLL relock time, the DRAM is ready to operate with new clock frequency.

8.10 Mode Register Operation

The mode register is programmed by the Mode Register Set command (MRS/EMRS) when all banks are in the idle state. The data to be set in the Mode Register is transferred using the A0 to A11 and BA0, BA1 address inputs.

The Mode Register designates the operation mode for the read or write cycle. The register is divided into five filed: (1) Burst Length field to set the length of burst data (2) Addressing Mode selected bit to designate the column access sequence in a Burst cycle (3) CAS Latency field to set the assess time in clock cycle (4) DLL reset field to reset the DLL (5) Regular/Extended Mode Register filed to select a type of MRS (Regular/Extended MRS). EMRS cycle can be implemented the extended function (DLL enable/Disable mode).

The initial value of the Mode Register (including EMRS) after power up is undefined; therefore the Mode Register Set command must be issued before power operation.

8.10.1 Burst Length field (A2 to A0)

This field specifies the data length for column access using the A2 to A0 pins and sets the Burst Length to be 2, 4 and 8 words.

A2	A1	A0	BURST LENGTH
0	0	0	Reserved
0	0	1	2 words
0	1	0	4 words
0	1	1	8 words
1	х	х	Reserved

8.10.2 Addressing Mode Select (A3)

The Addressing Mode can be one of two modes; Interleave mode or Sequential Mode, When the A3 bit is "0", Sequential mode is selected. When the A3 bit is "1", Interleave mode is selected. Both addressing Mode support burst length 2, 4 and 8 words.

A3	ADDRESSING MODE
0	Sequential
1	Interleave

8.10.2.1. Addressing Sequence of Sequential Mode

A column access is performed by incrementing the column address input to the device. The address is varied by the Burst Length as the following.

DATA	ACCESS ADDRESS	BURST LENGTH
Data 0	n	2 words (address bits is A0)
Data 1	n + 1	not carried from A0 to A1
Data 2	n + 2	4 words (address bit A0, A1)
Data 3	n + 3	Not carried from A1 to A2
Data 4	n + 4	
Data 5	n + 5	8 words (address bits A2, A1 and A0)
Data 6	n + 6	Not carried from A2 to A3
Data 7	n + 7	

Addressing Sequence of Sequential Mode

8.10.2.2. Addressing Sequence for Interleave Mode

A Column access is started from the inputted column address and is performed by interleaving the address bits in the sequence shown as the following.

DATA	ACCESS ADDRESS	BURST LENGTH
Data 0	A8 A7 A6 A5 A4 A3 A2 A1 A0	2 words
Data 1	A8 A7 A6 A5 A4 A3 A2 A1 A0	
Data 2	A8 A7 A6 A5 A4 A3 A2 A1 A0	4 words
Data 3	A8 A7 A6 A5 A4 A3 A2 A1 A0	
Data 4	A8 A7 A6 A5 A4 A3 A2 A1 A0	8 words
Data 5	A8 A7 A6 A5 A4 A3 A2 A1 A0	
Data 6	A8 A7 A6 A5 A4 A3 A2 A1 A0	
Data 7	A8 A7 A6 A5 A4 A3 A2 A1 A0	ν

Addressing Sequence of Interleave Mode



8.10.3 CAS Latency field (A6 to A4)

This field specifies the number of clock cycles from the assertion of the Read command to the first data read. The minimum values of CAS Latency depend on the frequency of CLK.

A6	A5	A4	CAS LATENCY
0	0	0	Reserved
0	0	1	Reserved
0	1	0	2
0	1	1	3
1	0	0	Reserved
1	0	1	Reserved
1	1	0	2.5
1	1	1	Reserved

8.10.4 DLL Reset bit (A8)

This bit is used to reset DLL. When the A8 bit is "1", DLL is reset.

8.10.5 Mode Register / Extended Mode register change bits (BA0, BA1)

These bits are used to select MRS/EMRS.

BA1	BA0	A11-A0
0	0	Regular MRS Cycle
0	1	Extended MRS Cycle
1	x	Reserved

8.10.6 Extended Mode Register field

1) DLL Switch field (A0)

This bit is used to select DLL enable or disable

A0	DLL
0	Enable
1	Disable

2) Output Driver Strength Control field (A6, A1)

The 100%, 60% and 30% or matched impedance driver strength are required Extended Mode Register Set (EMRS) as the following:

A6	A1	BUFFER STRENGTH
0	0	100% Strength
0	1	60% Strength
1	0	Reserved
1	1	30% Strength

8.10.7 Reserved field

- Test mode entry bit (A7) This bit is used to enter Test mode and must be set to "0" for normal operation.
- Reserved bits (A9, A10, A11) These bits are reserved for future operations. They must be set to "0" for normal operation.



9. OPERATION MODE

The following table shows the operation commands.

9.1 Simplified Truth Table

SYM.	COMMAND	DEVICE STATE	CKEn-1	CKEn	DM ⁽⁴⁾	BA0, BA1	A10	A0-A9 ,A11	cs	RAS	CAS	WE
ACT	Bank Active	Idle ⁽³⁾	Н	Х	Х	V	V	V	L	L	Н	Н
PRE	Bank Precharge	Any ⁽³⁾	Н	Х	Х	V	L	Х	L	L	Н	L
PREA	Precharge All	Any	Н	Х	Х	Х	Н	Х	L	L	Н	L
WRIT	Write	Active ⁽³⁾	Н	Х	Х	V	L	V	L	Н	L	L
WRITA	Write with Auto- precharge	Active ⁽³⁾	Н	Х	Х	V	Н	V	L	н	L	L
READ	Read	Active ⁽³⁾	Н	Х	Х	V	L	V	L	Н	L	Н
READA	Read with Auto- precharge	Active ⁽³⁾	Н	Х	Х	V	Н	V	L	Н	L	Н
MRS	Mode Register Set	Idle	Н	Х	Х	L, L			L	L	L	L
EMRS	Extended Mode Register Set	ldle	Н	х	х	H, L	Op-0	Code ⁽⁶⁾	L	L	L	L
NOP	No Operation	Any	Н	Х	Х	Х	Х	Х	L	Н	Н	Н
BST	Burst Read Stop	Active	Н	Х	Х	Х	Х	Х	L	Н	Н	L
DSL	Device Deselect	Any	Н	Х	Х	Х	Х	Х	Н	Х	Х	Х
AREF	Auto Refresh	Idle	Н	Н	Х	Х	Х	Х	L	L	L	Н
SELF	Self Refresh Entry	ldle	Н	L	Х	Х	Х	х	L	L	L	Н
	Solf Defreeb Evit	Idle (Self		Ц	v	v	~	×	Н	Х	Х	Х
SELEA	Sell hellesit Exit	Refresh)	L		^	^	^	~	L	Н	Н	Х
חם	Power Down	ldle/	Ц	1	v	v	×	v	Н	Х	Х	Х
ΓD	Mode Entry	Active ⁽⁵⁾		L	~	~	~	~	L	Н	Н	Х
DDEV	Power Down	Any			V	V	X	X	Н	Х	Х	Х
PDEX	Mode Exit	(Power Down)	L	н	X	X	X	X	L	н	Н	х
WDE	Data Write Enable	Active	Н	Х	L	Х	Х	Х	Х	Х	Х	Х
WDD	Data Write Disable	Active	Н	Х	Н	Х	Х	Х	Х	Х	Х	Х

Notes:

1. V = Valid X = Don't Care L = Low level H = High level.

- CKE_n signal is input level when commands are issued CKE_{n-1} signal is input level one clock cycle before the commands are issued
- 3. These are state designated by the BA0, BA1 signals.
- 4. LDM, UDM (W9412G6KH)
- 5. Power Down Mode can not entry in the burst cycle.
- BA0, BA1 select either the Base or the Extended Mode Register (BA0 = 0, BA1 = 0 selects Mode Register; BA0 = 1, BA1 = 0 selects Extended Mode Register; other combinations of BA0, BA1 are reserved; A0~A11 provide the op-code to be written to the selected Mode Register (MRS or EMRS).

9.2 Function Truth Table

(Note 1)

CURRENT STATE	cs	RAS	CAS	WE	ADDRESS	COMMAND	ACTION	NOTES
	Н	Х	Х	Х	Х	DSL	NOP	
	L	Н	Н	Х	Х	NOP/BST	NOP	
	L	н	L	н	BA, CA, A10	READ/READA	ILLEGAL	3
Idlo	L	н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
luie	L	L	Н	Н	BA, RA	ACT	Row activating	
	L	L	Н	L	BA, A10	PRE/PREA	NOP	
	L	L	L	Н	Х	AREF/SELF	Refresh or Self refresh	2
	L	L	L	L	Op-Code	MRS/EMRS	Mode register accessing	2
	Н	Х	Х	Х	Х	DSL	NOP	
	L	Н	Н	Х	Х	NOP/BST	NOP	
	L	н	L	н	BA, CA, A10	READ/READA	Begin read: Determine AP	4
Bow Active	L	н	L	L	BA, CA, A10	WRIT/WRITA	Begin write: Determine AP	4
	L	L	Н	н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	Precharge	5
	L	L	L	Н	Х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	Х	DSL	Continue burst to end	
	L	Н	Н	н	Х	NOP	Continue burst to end	
	L	Н	Н	L	Х	BST	Burst stop	
	L	Н	L	Н	BA, CA, A10	READ/READA	Term burst, new read: Determine AP	6
Read	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	
	L	L	Н	н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	Term burst, precharging	
	L	L	L	н	Х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	н	Х	Х	Х	Х	DSL	Continue burst to end	
	L	н	Н	н	Х	NOP	Continue burst to end	
	L	н	Н	L	Х	BST	ILLEGAL	
	L	Н	L	Н	BA, CA, A10	READ/READA	Term burst, start read: Determine AP	6, 7
Write	L	н	L	L	BA, CA, A10	WRIT/WRITA	Term burst, start read: Determine AP	6
	L	L	Н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	Term burst, precharging	8
	L	L	L	Н	Х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	

Function Truth Ta	ble, continued
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CURRENT STATE	CS	RAS	CAS	WE	ADDRESS	COMMAND	ACTION	NOTES
	Н	Х	Х	Х	Х	DSL	Continue burst to end	
	L	Н	Н	Н	Х	NOP	Continue burst to end	
	L	Н	Н	L	Х	BST	ILLEGAL	
Read with	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	
Auto-	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
precharge	L	L	н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	ILLEGAL	
	L	L	L	Н	Х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	Х	DSL	Continue burst to end	
	L	н	Н	Н	х	NOP	Continue burst to end	
	L	н	Н	L	Х	BST	ILLEGAL	
Write with	L	н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	
Auto-	L	н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	
precharge	L	L	Н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	ILLEGAL	3
	L	L	L	Н	Х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	Х	DSL	NOP-> Idle after tRP	
	L	Н	Н	Н	Х	NOP	NOP-> Idle after tRP	
	L	н	Н	L	Х	BST	ILLEGAL	
	L	н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	3
Precharging	L	н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	Н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	Idle after tRP	
	L	L	L	Н	х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	Х	DSL	NOP-> Row active after tRCD	
	L	н	Н	Н	Х	NOP	NOP-> Row active after tRCD	
	L	н	Н	L	Х	BST	ILLEGAL	
	L	н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	3
Row Activating	L	н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
	L	L	Н	н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	ILLEGAL	3
	L	L	L	Н	х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	

Function Truth Table, continued

CURRENT STATE	cs	RAS	CAS	WE	ADDRESS	COMMAND	ACTION	NOTES
	Н	Х	Х	Х	Х	DSL	NOP->Row active after twR	
	L	Н	Н	Н	Х	NOP	NOP->Row active after twn	
	L	Н	Н	L	х	BST	ILLEGAL	
	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	3
Write	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
necovering	L	L	Н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	ILLEGAL	3
	L	L	L	Н	х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	х	DSL	NOP->Enter precharge after twR	
	L	Н	Н	Н	х	NOP	NOP->Enter precharge after twR	
	L	Н	Н	L	х	BST	ILLEGAL	
Write	L	Н	L	Н	BA, CA, A10	READ/READA	ILLEGAL	3
Recovering with Auto-	L	Н	L	L	BA, CA, A10	WRIT/WRITA	ILLEGAL	3
precharge	L	L	Н	Н	BA, RA	ACT	ILLEGAL	3
	L	L	Н	L	BA, A10	PRE/PREA	ILLEGAL	3
	L	L	L	Н	х	AREF/SELF	ILLEGAL	
	L	L	L	L	Op-Code	MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	х	DSL	NOP->Idle after tRC	
	L	Н	Н	Н	х	NOP	NOP->Idle after tRC	
Defreebing	L	Н	Н	L	х	BST	ILLEGAL	
nellesillig	L	Н	L	Н	х	READ/WRIT	ILLEGAL	
	L	L	Н	Х	х	ACT/PRE/PREA	ILLEGAL	
	L	L	L	Х	х	AREF/SELF/MRS/EMRS	ILLEGAL	
	Н	Х	Х	Х	х	DSL	NOP->Row after tMRD	
	L	н	Н	Н	х	NOP	NOP->Row after tMRD	
Mode Register	L	н	Н	L	Х	BST	ILLEGAL	
Accessing	L	Н	L	Х	х	READ/WRIT	ILLEGAL	
	L	L	х	х	x	ACT/PRE/PREA/ARE F/SELF/MRS/EMRS	ILLEGAL	

Notes:

1. All entries assume that CKE was active (High level) during the preceding clock cycle and the current clock cycle.

2. Illegal if any bank is not idle.

3. Illegal to bank in specified states; Function may be legal in the bank indicated by Bank Address (BA), depending on the state of that bank.

- 4. Illegal if tRCD is not satisfied.
- 5. Illegal if tRAS is not satisfied.
- 6. Must satisfy burst interrupt condition.
- 7. Must avoid bus contention, bus turn around, and/or satisfy write recovery requirements.
- 8. Must mask preceding data which don't satisfy twn

Remark: H = High level, L = Low level, X = High or Low level (Don't Care), V = Valid data

9.3 Function Truth Table for CKE

CURRENT	CKE								NOTES
STATE	n-1	n	cs	RAS	CAS	WE	ADDRESS	ACTION	NOTES
	Н	Х	Х	Х	Х	Х	Х	INVALID	
	L	Н	н	Х	Х	Х	Х	Exit Self Refresh->Idle after txsnR	
Colf Dofroch	L	Н	L	н	Н	Х	Х	Exit Self Refresh->Idle after txsnR	
Sell Refresh	L	Н	L	Н	L	Х	Х	ILLEGAL	
	L	Н	L	L	Х	Х	Х	ILLEGAL	
	L	L	Х	Х	Х	Х	Х	Maintain Self Refresh	
	Н	Х	Х	Х	Х	Х	Х	INVALID	
Power Down	L	Н	Х	Х	Х	Х	Х	Exit Power down->Idle after tis	
	L	L	Х	Х	Х	Х	Х	Maintain power down mode	
	Н	Н	Х	Х	Х	Х	Х	Refer to Function Truth Table	
	Н	L	н	Х	Х	Х	Х	Enter Power down	2
	Н	L	L	Н	Н	Х	Х	Enter Power down	2
All banks Idle	Н	L	L	L	L	Н	Х	Self Refresh	1
	Н	L	L	н	L	Х	Х	ILLEGAL	
	Н	L	L	L	Х	Х	Х	ILLEGAL	
	L	Х	Х	Х	Х	Х	Х	Power down	
	Н	Н	Х	Х	Х	Х	Х	Refer to Function Truth Table	
	Н	L	Н	Х	Х	Х	Х	Enter Power down	3
	Н	L	L	н	Н	Х	Х	Enter Power down	3
Row Active	Н	L	L	L	L	Н	Х	ILLEGAL	
	Н	L	L	н	L	Х	Х	ILLEGAL	
	Н	L	L	L	Х	Х	Х	ILLEGAL	
	L	Х	Х	Х	Х	Х	Х	Power down	
Any State Other Than Listed Above	н	н	x	х	х	х	х	Refer to Function Truth Table	

Notes:

1. Self refresh can enter only from the all banks idle state.

2. Power Down occurs when all banks are idle; this mode is referred to as precharge power down.

3. Power Down occurs when there is a row active in any bank; this mode is referred to as active power down.

Remark: H = High level, L = Low level, X = High or Low level (Don't Care), V = Valid data

9.4 Simplified Stated Diagram



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10. ELECTRICAL CHARACTERISTICS

10.1 Absolute Maximum Ratings

PARAMETER	SYMBOL	RATING	UNIT
Voltage on I/O Pins Relative to VSS	Vin, Vout	-0.5 ~ VDDQ +0.5	V
Voltage on Input Pins Relative to Vss	VIN	-1 ~ 3.6	V
Voltage on VDD Supply Relative to VSS	Vdd	-1 ~ 3.6	V
Voltage on VDDQ Supply Relative to VSS	Vddq	-1 ~ 3.6	V
Operating Temperature (-5)	Topr	0 ~ 70	°C
Operating Temperature (-5I/-6I)	Topr	-40 ~ 85	°C
Storage Temperature	Тѕтс	-55 ~ 150	°C
Soldering Temperature (10s)	TSOLDER	260	°C
Power Dissipation	PD	1	W
Short Circuit Output Current	Ιουτ	50	mA

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Exposure to absolute maximum rating conditions for extended periods may affect reliability.

10.2 Recommended DC Operating Conditions

 $(TA = 0 \text{ to } 70^{\circ}\text{C for } -5, TA = -40 \text{ to } 85^{\circ}\text{C for } -5I/-6I)$

SYM.	PARAMETER	MIN.	TYP.	MAX.	UNIT	NOTES
Vdd	Power Supply Voltage (for -5/-5I/-6I)	2.3	2.5	2.7	V	2
Vddq	I/O Buffer Supply Voltage (for -5/-5I/-6I)	2.3	2.5	2.7	V	2
VREF	Input reference Voltage	0.49 x VDDQ	0.50 x Vddq	0.51 x VDDQ	V	2, 3
Vtt	Termination Voltage (System)	Vref - 0.04	VREF	Vref + 0.04	V	2, 8
VIH (DC)	Input High Voltage (DC)	VREF + 0.15	-	VDDQ + 0.3	V	2
VIL (DC)	Input Low Voltage (DC)	-0.3	-	Vref - 0.15	V	2
VICK (DC)	Differential Clock DC Input Voltage	-0.3	-	VDDQ + 0.3	V	15
VID (DC)	Input Differential Voltage. CLK and CLK inputs (DC)	0.36	-	VDDQ + 0.6	V	13, 15
VIH (AC)	Input High Voltage (AC)	VREF + 0.31	-	-	V	2
VIL (AC)	Input Low Voltage (AC)	-	-	Vref - 0.31	V	2
VID (AC)	Input Differential Voltage. CLK and CLK inputs (AC)	0.7	-	VDDQ + 0.6	V	13, 15
VX (AC)	Differential AC input Cross Point Voltage	VDDQ/2 - 0.2	-	VDDQ/2 + 0.2	V	12, 15
VISO (AC)	Differential Clock AC Middle Point	VDDQ/2 - 0.2	-	VDDQ/2 + 0.2	V	14, 15

Notes: VIH (DC) and VIL (DC) are levels to maintain the current logic state. VIH (AC) and VIL (AC) are levels to change to the new logic state.

10.3 Capacitance

(VDD = VDDQ = 2.5V ± 0.2V, f = 1 MHz, TA = 25°C, VOUT (DC) = VDDQ/2, VOUT (Peak to Peak) = 0.2V)

SYMBOL	PARAMETER	MIN.	MAX.	DELTA (MAX.)	UNIT
CIN	Input Capacitance (except for CLK pins)	2.0	4.0	0.5	pF
CCLK	Input Capacitance (CLK pins)	3.0	5.0	0.25	pF
CI/O	DQ, DQS, DM Capacitance	1.5	5.5	0.5	pF

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Notes: These parameters are periodically sampled and not 100% tested.

10.4 Leakage and Output Buffer Characteristics

SYMBOL	PARAMETER	MIN.	MAX.	UNIT	NOTES
lı (L)	Input Leakage Current Any input $0V \le V_{IN} \le V_{DD}$, VREF Pin $0V \le V_{IN} \le 1.35V$ (All other pins not under test = $0V$)	-2	2	μA	
IO (L)	Output Leakage Current (Output disabled, 0V ≤ Vou⊤ ≤ Vppq)	-5	5	μA	
Vон	Output High Voltage (under AC test load condition)	V⊤⊤ +0.76	-	V	
Vol	Output Low Voltage (under AC test load condition)	-	Vtt -0.76	V	
Іон	Output Levels: Full drive option High Current (VOUT = VDDQ - 0.373V, min. VREF, min. VTT	-15	-	mA	4, 6
IOL	Low Current (VOUT = 0.373V, max. VREF, max. VTT)	15	-	mA	4, 6
Iohr	Output Levels: Reduced drive option - 60% High Current (VOUT = VDDQ - 0.763V, min. VREF, min. VTT	-9	-	mA	5
Iolr	Low Current (Vout = 0.763V, max. VREF, max. Vtt)	9	-	mA	5
IOHR(30)	Output Levels: Reduced drive option - 30% High Current (VOUT = VDDQ - 1.056V, min. VREF, min. VTT	-4.5	-	mA	5
IOLR(30)	Low Current (Vout = 1.056V, max. VREF, max. VTT)	4.5	-	mA	5



10.5 DC Characteristics

SYM.	DADAMETER	MAX.			
	PARAMETER		-61	UNIT	NOTES
IDD0	Operating current: One Bank Active-Precharge; tRc = tRc min; tcκ = tcκ min; DQ, DM and DQS inputs changing once per clock cycle; Address and control inputs changing once every two clock cycles	55	50		7
IDD1	Operating current: One Bank Active-Read-Precharge; Burst = 4; tRc = tRc min; $CL = 3$; tck = tck min; lout = 0 mA; Address and control inputs changing once per clock cycle.	65	55		7, 9
IDD2P	Precharge Power Down standby current: All Banks Idle; Power down mode; CKE ≤ VI∟ max; tck = tck min; Vin = VREF for DQ, DQS and DM	5	5		
IDD2N	Idle standby current:	20	20		7
IDD3P	Active Power Down standby current: One Bank Active; Power down mode; CKE ≤ VIL max; tck = tck min; Vin = VREF for DQ, DQS and DM	10	10		
IDD3N	Active standby current: $\overline{CS} \ge V_{IH} \text{ min}; CKE \ge V_{IH} \text{ min}; One Bank Active-Precharge;}$ $t_{RC} = t_{RAS} \text{ max}; t_{CK} = t_{CK} \text{ min};$ DQ, DM and DQS inputs changing twice per clock cycle; Address and other control inputs changing once per clock cycle	30	30	mA	7
IDD4R	Operating current: Burst = 2; Reads; Continuous burst; One Bank Active; Address and control inputs changing once per clock cycle; CL=2; tck = tck min; lout = 0mA	120	110		7, 9
IDD4W	Operating current: Burst = 2; Write; Continuous burst; One Bank Active; Address and control inputs changing once per clock cycle; CL = 2; tcк = tcк min; DQ, DM and DQS inputs changing twice per clock cycle	115	100		7
IDD5	Auto Refresh current: tRc = tRFc min	70	65		7
IDD6	Self Refresh current: CKE ≤ 0.2V; external clock on; tcк = tcк min	2	2]	
IDD7	Random Read current: 4 Banks Active Read with activate every 20nS, Auto-Precharge Read every 20 nS; Burst = 4; tRCD = 3; lout = 0mA; DQ, DM and DQS inputs changing twice per clock cycle; Address changing once per clock cycle	150	130		